

FCC Test Report

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Test Model: F-04K

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FCC Registration /

788550 / TW0003

Designation Number:





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Release Control Record

Issue No.	Description	Date Issued
RF171221C06	Original Release	Mar. 05, 2018
RF171221C06 R1	Revise battery voltage	Apr. 16, 2018

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1 Certificate of Conformity

Product: Smart Phone

Brand: FUJITSU

Test Model: F-04K

Sample Status: Identical Prototype

Applicant: Fujitsu Limited

Test Date: Feb. 14, 2018 ~ Feb. 27, 2018

Standards: 47 CFR FCC Part 15, Subpart C (Section 15.247)

ANSI C63.10:2013

The above equipment has been tested by **Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch**, and found compliance with the requirement of the above standards. The test record, data evaluation & Equipment Under Test (EUT) configurations represented herein are true and accurate accounts of the measurements of the sample's RF characteristics under the conditions specified in this report.

Ivonne Wu / Supervisor

Approved by : , Date: Apr. 16, 2018

Dylan Chiou / Project Engineer

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2 Summary of Test Results

	47 CFR FCC Part 15, Subpart C (Section 15.247)						
FCC Clause	Test Item	Result	Remarks				
15.207	AC Power Conducted Emission	Pass	Meet the requirement of limit. Minimum passing margin is -4.73 dB at 0.62689 MHz.				
15.247(a)(1) (iii)	Number of Hopping Frequency Used	Pass	Meet the requirement of limit.				
15.247(a)(1) (iii)	Dwell Time on Each Channel	Pass	Meet the requirement of limit.				
15.247(a)(1)	Hopping Channel Separation Spectrum Bandwidth of a Frequency Hopping Sequence Spread Spectrum System	Pass	Meet the requirement of limit.				
15.247(b)	Maximum Peak Output Power	Pass	Meet the requirement of limit.				
	Occupied Bandwidth Measurement	Pass	Reference only				
15.205 & 209	Radiated Emissions	Pass	Meet the requirement of limit. Minimum passing margin is -16.78 dB at 938.89 MHz.				
15.247(d)	Band Edge Measurement	Pass	Meet the requirement of limit.				
15.247(d)	Antenna Port Emission	Pass	Meet the requirement of limit.				
15.203	Antenna Requirement	Pass	No antenna connector is used.				

Note: If The Frequency Hopping System operating in 2400-2483.5 MHz band and the output power less than 125 mW. The hopping channel carrier frequencies separated by a minimum of 25 kHz or two-thirds of the 20 dB bandwidth of hopping channel whichever is greater.

2.1 Measurement Uncertainty

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the EUT:

The listed uncertainties are the worst case uncertainty for the entire range of measurement. Please note that the uncertainty values are provided for informational purposes only and are not used in determining the PASS/FAIL results.

Measurement	Frequency	Expended Uncertainty (k=2) (±)
Conducted Emissions at mains ports	150 kHz ~ 30 MHz	2.44 dB
Radiated Emissions up to 1 GHz	30 MHz ~ 200 MHz	2.93 dB
Radiated Effissions up to 1 GHz	200 MHz ~1000 MHz	2.95 dB
Radiated Emissions above 1 GHz	1 GHz ~ 18 GHz	2.26 dB
Radiated Emissions above 1 GHZ	18 GHz ~ 40 GHz	1.94 dB

2.2 Modification Record

There were no modifications required for compliance.

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3 **General Information**

General Description of EUT 3.1

Product	Smart Phone
Brand	FUJITSU
Test Model	F-04K
Status of EUT	Identical Prototype
Dower Supply Deting	5.0 Vdc (adapter or host equipment)
Power Supply Rating	3.8 Vdc (Li-ion battery)
Normal Testing Voltage	3.9 Vdc
Modulation Type	GFSK, π/4-DQPSK, 8DPSK
Transfer Rate	1/2/3 Mbps
Operating Frequency	2402 ~ 2480 MHz
Number of Channel	79
Output Power	13.552 mW
Antenna Type	λ/4 Monopole antenna with -2.0 dBi gain
Antenna Connector	N/A
Accessory Device	Refer to Note as below
Data Cable Supplied	Refer to Note as below

Note:

1. The EUT contains following accessory devices.

Product	Brand	Model	Description	
Pottony	FUJITSU CONNECTED	CA54310-0067	3.8 Vdc, 2580 mAh	
Battery	TECHNOLOGIES Ltd.	CA34310-0007		

2. The EUT uses following adapter which provided by client as support unit.

Product	Brand	Model	Description
A -lt	NTT I	A.O. A.dantan 04	I/P: 100-240Vac, 0.8A,
Adapter	NTT docomo	AC Adapter 01	O/P: 5.0Vdc, 3.0A

3. The above EUT information is declared by manufacturer and for more detailed features description, please refer to the manufacturer's specifications or User's Manual.

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3.2 Description of Test Modes

79 channels are provided to this EUT:

Channel	Freq. (MHz)						
0	2402	20	2422	40	2442	60	2462
1	2403	21	2423	41	2443	61	2463
2	2404	22	2424	42	2444	62	2464
3	2405	23	2425	43	2445	63	2465
4	2406	24	2426	44	2446	64	2466
5	2407	25	2427	45	2447	65	2467
6	2408	26	2428	46	2448	66	2468
7	2409	27	2429	47	2449	67	2469
8	2410	28	2430	48	2450	68	2470
9	2411	29	2431	49	2451	69	2471
10	2412	30	2432	50	2452	70	2472
11	2413	31	2433	51	2453	71	2473
12	2414	32	2434	52	2454	72	2474
13	2415	33	2435	53	2455	73	2475
14	2416	34	2436	54	2456	74	2476
15	2417	35	2437	55	2457	75	2477
16	2418	36	2438	56	2458	76	2478
17	2419	37	2439	57	2459	77	2479
18	2420	38	2440	58	2460	78	2480
19	2421	39	2441	59	2461		



3.2.1 Test Mode Applicability and Tested Channel Detail

EUT Configure		Applica	able To		Decorinties
Mode	RE≥1G	RE<1G	PLC	APCM	Description
-	V	√	√	√	-

Where

RE≥1G: Radiated Emission above 1 GHz

RE<1G: Radiated Emission below 1 GHz

PLC: Power Line Conducted Emission

APCM: Antenna Port Conducted Measurement

Note:

- 1. For Radiated emission test, pre-tested GFSK, π /4-DQPSK, 8DPSK modulation type and found 8DPSK was the worse, therefore chosen for the final test and presented in the test report.
- 2. The EUT had been pre-tested on the positioned of each 3 axis. The worst case was found when positioned on **Z-plane**.
- 3. "-" means no effect.

Radiated Emission Test (Above 1 GHz):

Pre-Scan has been conducted to determine the worst-case mode from all possible combinations between available modulations, data rates and antenna ports (if EUT with antenna diversity architecture).
 Following channel(s) was (were) selected for the final test as listed below.

EUT Configure Mode	Available Channel	Tested Channel	Modulation Technology	Modulation Type	Packet Type
-	0 to 78	0, 39, 78	FHSS	8DPSK	DH5

Radiated Emission Test (Below 1 GHz):

Pre-Scan has been conducted to determine the worst-case mode from all possible combinations between available modulations, data rates and antenna ports (if EUT with antenna diversity architecture).
 Following channel(s) was (were) selected for the final test as listed below.

EUT Configure Mode	Available Channel	Tested Channel	Modulation Technology	Modulation Type	Packet Type
-	0 to 78	78	FHSS	8DPSK	DH5

Power Line Conducted Emission Test:

Pre-Scan has been conducted to determine the worst-case mode from all possible combinations between available modulations, data rates and antenna ports (if EUT with antenna diversity architecture).
 Following channel(s) was (were) selected for the final test as listed below.

EUT Configure Mode	Available Channel Tested Channel		Modulation Technology	Modulation Type	Packet Type	
-	0 to 78	78	FHSS	8DPSK	DH5	

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Antenna Port Conducted Measurement:

This item includes all test value of each mode, but only includes spectrum plot of worst value of each mode.

Pre-Scan has been conducted to determine the worst-case mode from all possible combinations between available modulations, data rates and antenna ports (if EUT with antenna diversity architecture).

Following channel(s) was (were) selected for the final test as listed below.

EUT Configure Mode	Available Channel Tested Channel		Modulation Technology	Modulation Type	Packet Type	
-	0 to 78	0, 39, 78	FHSS	GFSK	DH5	
-	- 0 to 78 0, 39		FHSS	π/4-DQPSK	2DH5	
-	0 to 78	0, 39, 78	FHSS	8DPSK	3DH5	

Test Condition:

Applicable To	Environmental Conditions	Input Power	Tested by	
RE≥1G	25 deg. C, 65 % RH	120 Vac, 60 Hz	Getaz Yang	
RE<1G	25 deg. C, 65 % RH	120 Vac, 60 Hz	Getaz Yang	
PLC	25 deg. C, 65 % RH	120 Vac, 60 Hz	Getaz Yang	
APCM	25 deg. C, 65 % RH	3.9 Vdc	Vincent Huang	

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3.3 Description of Support Units

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

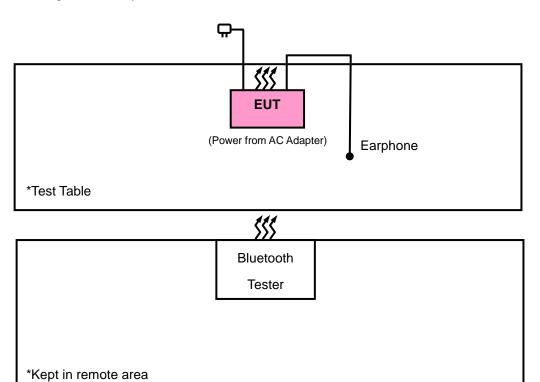
No.	Product Brand Model No.		Serial No.	FCC ID	
1.	Bluetooth Tester	R&S	CBT	100980	N/A
2.	Earphone	Apple	MD827FE	N/A	N/A

No.	Signal Cable Description Of The Above Support Units
1.	N/A
2.	N/A

Note:

- 1. All power cords of the above support units are non-shielded (1.8m).
- 2. Items 1 acted as communication partners to transfer data.

3.3.1 Configuration of System under Test



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3.4 General Description of Applied Standards

The EUT is a RF Product. According to the specifications of the manufacturer, it must comply with the requirements of the following standards:

FCC Part 15, Subpart C (15.247) FCC Public Notice DA 00-705

ANSI C63.10-2013

All test items have been performed and recorded as per the above standards.

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4 Test Types and Results

4.1 Radiated Emission and Bandedge Measurement

4.1.1 Limits of Radiated Emission and Bandedge Measurement

Radiated emissions which fall in the restricted bands must comply with the radiated emission limits specified as below table. Other emissions shall be at least 20 dB below the highest level of the desired power:

Frequencies (MHz)	Field Strength (microvolts/meter)	Measurement Distance (meters)		
0.009 ~ 0.490	2400/F (kHz)	300		
0.490 ~ 1.705	24000/F (kHz)	30		
1.705 ~ 30.0	30	30		
30 ~ 88	100	3		
88 ~ 216	150	3		
216 ~ 960	200	3		
Above 960	500	3		

Note:

- 1. The lower limit shall apply at the transition frequencies.
- 2. Emission level $(dBuV/m) = 20 \log Emission level (uV/m)$.
- 3. For frequencies above 1000 MHz, the field strength limits are based on average detector, however, the peak field strength of any emission shall not exceed the maximum permitted average limits, specified above by more than 20 dB under any condition of modulation.

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4.1.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Date of Calibration	Due Date of Calibration	
Test Receiver Agilent	N9038A	MY52260177	Jul. 05, 2017	Jul. 04, 2018	
Spectrum Analyzer Agilent	N9010A	MY52220314	Nov. 24, 2017	Nov. 23, 2018	
Spectrum Analyzer ROHDE & SCHWARZ	FSU43	100115	Nov. 23, 2017	Nov. 22, 2018	
Double Ridge Guide Horn Antenna EMCO	3115	5619	Nov. 30, 2017	Nov. 29, 2018	
BILOG Antenna SCHWARZBECK	VULB 9168	9168-153	Dec. 06, 2017	Dec. 05, 2018	
RF signal cable ETS-LINDGREN	5D-FB	Cable-CH1-01(R FC-SMS-100-SM S-120+RFC-SMS -100-SMS-400)	Jun. 23, 2017	Jun. 22, 2018	
MXG Vector signal generator Agilent	N5182B	MY53050430	Oct. 24, 2017	Oct. 23, 2018	
Loop Antenna	EM-6879	269	Aug. 11, 2017	Aug. 10, 2018	
Preamplifier EMCI	EMC001340	980201	Nov. 01, 2017	Oct. 30, 2018	
Bluetooth Tester	СВТ	100946	Jul. 29, 2016	Jul. 28, 2018	
Preamplifier EMCI	EMC 012645	980115	Oct. 20, 2017	Oct. 19, 2018	
Preamplifier EMCI	EMC 184045	980116	Oct. 20, 2017	Oct. 19, 2018	
Preamplifier EMCI	EMC 330H	980112	Oct. 13, 2017	Oct. 12, 2018	
Power Meter Anritsu	ML2495A	1012010	Aug. 15, 2017	Aug. 14, 2018	
Power Sensor Anritsu	MA2411B	1315050	Aug. 15, 2017	Aug. 14, 2018	
RF Coaxial Cable HUBER+SUHNNER	EMC104-SM-SM-8 000&3000	140811+170717	Oct. 20, 2017	Oct. 19, 2018	
RF Coaxial Cable HUBER+SUHNNER	SUCOFLEX 104	EMC104-SM-SM- 1000(140807)	Oct. 20, 2017	Oct. 19, 2018	
RF Coaxial Cable Worken	8D-FB	Cable-Ch10-01	Oct. 20, 2017	Oct. 19, 2018	
Software BV ADT	E3 6.120103	NA	NA	NA	
Antenna Tower MF	MFA-440H	NA	NA	NA	
Turn Table MF	MFT-201SS	NA	NA	NA	
Antenna Tower &Turn Table Controller MF	MF-7802	NA	NA	NA	



Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.	
2. The test was performed in HwaYa Chamber 10.	
The horn antenna and preamplifier (model: EMC 184045) are used only for the measurement of emission frequency above 1 GHz if tested.	
4. The IC Site Registration No. is IC7450F-10.	

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4.1.3 Test Procedures

- a. The EUT was placed on the top of a rotating table 0.8 meters (for below 1 GHz) / 1.5 meters (for above 1 GHz) above the ground at 3 meter chamber room for test. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- c. The height of antenna is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- e. The test-receiver system was set to quasi-peak detect function and specified bandwidth with maximum hold mode when the test frequency is below 1 GHz.
- f. The test-receiver system was set to peak and average detected function and specified bandwidth with maximum hold mode when the test frequency is above 1 GHz. If the peak reading value also meets average limit, measurement with the average detector is unnecessary.

Note:

- 1. The resolution bandwidth and video bandwidth of test receiver/spectrum analyzer is 120 kHz & 360 kHz for Quasi-peak detection (QP) at frequency below 1 GHz.
- 2. The resolution bandwidth of test receiver/spectrum analyzer is 1 MHz and the video bandwidth is 3 MHz for Peak detection (PK) at frequency above 1 GHz.
- 3. The resolution bandwidth of test receiver/spectrum analyzer is 1 MHz and the video bandwidth is 1/T for Average (Duty cycle < 98 %) detection at frequency above 1 GHz.
- 4. The resolution bandwidth of test receiver/spectrum analyzer is 1 MHz and the video bandwidth is 10 Hz (Duty cycle ≥ 98 %) for Average detection (AV) at frequency above 1 GHz.
- 5. All modes of operation were investigated and the worst-case emissions are reported.

4.1.4 Deviation from Test Standard

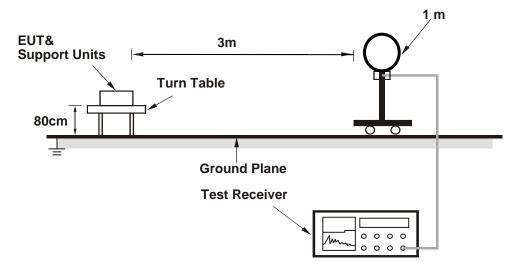
No deviation.

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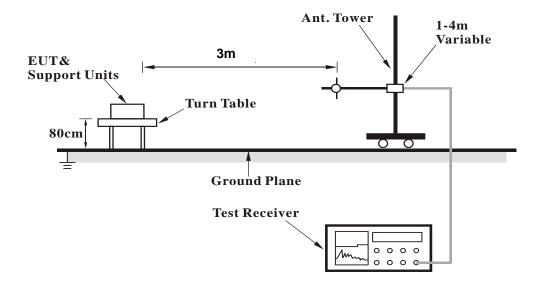


4.1.5 Test Set Up

<Radiated emission below 30 MHz>

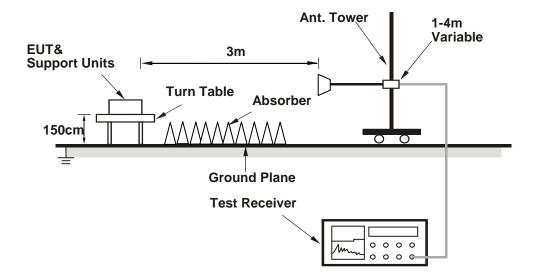


<Frequency Range below 1 GHz>





<Frequency Range above 1 GHz>



For the actual test configuration, please refer to the attached file (Test Setup Photo).

4.1.6 **EUT Operating Conditions**

Set the EUT under transmission condition continuously at specific channel frequency.

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4.1.7 Test Results

Above 1 GHz Data:

8DPSK

EUT Test Condition		Measurement Detail			
Channel 0		Frequency Range	1 GHz ~ 25 GHz		
Input Power	120 Vac, 60 Hz	Detector Function	Peak (PK) Average (AV)		
Environmental Conditions	25 deg. C, 65 % RH	Tested By	Getaz Yang		

	Antenna Polarity & Test Distance: Horizontal at 3 m									
Frequency (MHz)	Emission Level (dBuV/m)	Read Level (dBuV)	Limit (dBuV/m)	Margin (dB)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Antenna Height (cm)	Table Angle (Degree)	Remark
2385.6	35.39	41.38	54	-18.61	27.16	4.35	37.5	205	344	Average
2385.6	47.09	53.24	74	-26.91	27.01	4.33	37.49	205	344	Peak
2402	76.89	82.88			27.16	4.37	37.52	205	344	Average
2402	106.99	112.98			27.16	4.37	37.52	205	344	Peak
4804	12.42	27.56	54	-41.58	30.97	6.79	52.9	135	99	Average
4804	42.52	57.66	74	-31.48	30.97	6.79	52.9	135	99	Peak
		A	ntenna P	olarity &	Test Dista	ance: Vert	ical at 3 r	n		
Frequency (MHz)	Emission Level (dBuV/m)	Read Level (dBuV)	Limit (dBuV/m)	Margin (dB)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Antenna Height (cm)	Table Angle (Degree)	Remark
2389.66	34.95	41.03	54	-19.05	27.08	4.34	37.5	161	264	Average
2389.66	48.98	54.96	74	-25.02	27.16	4.36	37.5	161	264	Peak
2402	70.56	76.55			27.16	4.37	37.52	161	264	Average
2402	100.66	106.65			27.16	4.37	37.52	161	264	Peak
4804	13.04	28.38	54	-40.96	30.97	6.79	53.1	170	116	Average
4804	43.14	58.48	74	-30.86	30.97	6.79	53.1	170	116	Peak

Remarks:

- 1. Emission Level = Read Level + Antenna Factor + Cable Loss Preamp Factor Margin value = Emission level - Limit value
- 2. 2402 MHz: Fundamental frequency.

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EUT Test Condition		Measurement Detail			
Channel	Channel 39	Frequency Range	1 GHz ~ 25 GHz		
Input Power	120 Vac, 60 Hz	Detector Function	Peak (PK) Average (AV)		
Environmental Conditions	25 deg. C, 65 % RH	Tested By	Getaz Yang		

	Antenna Polarity & Test Distance: Horizontal at 3 m									
Frequency (MHz)	Emission Level (dBuV/m)	Read Level (dBuV)	Limit (dBuV/m)	Margin (dB)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Antenna Height (cm)	Table Angle (Degree)	Remark
2389.8	34.36	40.36	54	-19.64	27.16	4.36	37.52	207	337	Average
2389.8	47.06	53.14	74	-26.94	27.08	4.34	37.5	207	337	Peak
2441	76.8	82.41			27.38	4.4	37.39	207	337	Average
2441	106.9	112.51			27.38	4.4	37.39	207	337	Peak
2488.92	17.49	22.77	54	-36.51	27.61	4.43	37.32	207	337	Average
2488.92	47.59	52.79	74	-26.41	27.61	4.44	37.25	207	337	Peak
4882	13.93	28.86	54	-40.07	31.06	6.87	52.86	133	102	Average
4882	44.03	58.96	74	-29.97	31.06	6.87	52.86	133	102	Peak
		A	ntenna P	olarity &	Test Dista	ance: Vert	ical at 3 r	n		
Frequency (MHz)	Emission Level (dBuV/m)	Read Level (dBuV)	Limit (dBuV/m)	Margin (dB)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Antenna Height (cm)	Table Angle (Degree)	Remark
2389.8	34.55	40.62	54	-19.45	27.08	4.35	37.5	176	263	Average
2389.8	48.06	54.06	74	-25.94	27.16	4.36	37.52	176	263	Peak
2441	70.55	76.16			27.38	4.4	37.39	176	263	Average
2441	100.65	106.26			27.38	4.4	37.39	176	263	Peak
2490.56	17.48	22.68	54	-36.52	27.61	4.44	37.25	176	263	Average
2490.56	47.58	52.86	74	-26.42	27.61	4.43	37.32	176	263	Peak
4882	13.64	28.77	54	-40.36	31.06	6.86	53.05	165	111	Average
4882	43.74	58.87	74	-30.26	31.06	6.86	53.05	165	111	Peak

Remarks:

- 1. Emission Level = Read Level + Antenna Factor + Cable Loss Preamp Factor Margin value = Emission level - Limit value
- 2. 2441 MHz: Fundamental frequency.

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EUT Test Condition		Measurement Detail			
Channel	Channel 78	Frequency Range	1 GHz ~ 25 GHz		
Input Power	120 Vac, 60 Hz	Detector Function	Peak (PK) Average (AV)		
Environmental Conditions	25 deg. C, 65 % RH	Tested By	Getaz Yang		

		An	tenna Po	larity & To	est Distar	nce: Horiz	ontal at 3	m		
Frequency (MHz)	Emission Level (dBuV/m)	Read Level (dBuV)	Limit (dBuV/m)	Margin (dB)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Antenna Height (cm)	Table Angle (Degree)	Remark
2480	77.43	82.79			27.53	4.43	37.32	205	333	Average
2480	107.53	112.89			27.53	4.43	37.32	205	333	Peak
2483.52	27	32.36	54	-27	27.53	4.43	37.32	205	333	Average
2483.52	57.11	62.47	74	-16.89	27.53	4.43	37.32	205	333	Peak
4960	15.55	30.17	54	-38.45	31.4	6.9	52.92	164	119	Average
4960	45.65	60.27	74	-28.35	31.4	6.9	52.92	164	119	Peak
		Α	ntenna P	olarity &	Test Dista	ance: Vert	ical at 3 r	n		
Frequency (MHz)	Emission Level (dBuV/m)	Read Level (dBuV)	Limit (dBuV/m)	Margin (dB)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Antenna Height (cm)	Table Angle (Degree)	Remark
2480	70.15	75.51			27.53	4.43	37.32	193	245	Average
2480	100.45	105.81		·	27.53	4.43	37.32	193	245	Peak
2483.64	19.82	25.18	54	-34.18	27.53	4.43	37.32	193	245	Average

27.53

31.16

31.16

4.43

6.9

6.9

37.32

53.04

53.04

193

133

133

245

94

94

Peak

Average

Peak

4960 Remarks:

2483.64

4960

1. Emission Level = Read Level + Antenna Factor + Cable Loss - Preamp Factor Margin value = Emission level – Limit value

-24.08

-38.87

-28.57

74

54

74

2. 2480 MHz: Fundamental frequency.

55.28

30.11

60.41

49.92

15.13

45.43

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9 kHz ~ 30 MHz Data:

The amplitude of spurious emissions attenuated more than 20 dB below the permissible value is not required to be report.

30 MHz ~ 1 GHz Worst-Case Data:

EUT Test Condition		Measurement Detail		
Channel	Channel 78	Frequency Range	30 MHz ~ 1 GHz	
Input Power	120 Vac, 60 Hz	Detector Function	Peak (PK) Quasi-peak (QP)	
Environmental Conditions	25 deg. C, 65 % RH	Tested By	Getaz Yang	

		An	tenna Po	larity & To	est Distar	nce: Horiz	ontal at 3	m		
Frequency (MHz)	Emission Level (dBuV/m)	Read Level (dBuV)	Limit (dBuV/m)	Margin (dB)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Antenna Height (cm)	Table Angle (Degree)	Remark
43.58	19.88	36.9	40	-20.12	13.59	0.5	31.11	152	236	Peak
161.92	22.96	41.24	43.5	-20.54	12.54	1.03	31.85	111	154	Peak
169.68	23	41.9	43.5	-20.5	11.76	1.07	31.73	102	256	Peak
453.89	19.8	33.07	46	-26.2	16.41	2.3	31.98	111	145	Peak
795.33	27.39	32.99	46	-18.61	22.16	3.66	31.42	102	256	Peak
951.5	29.36	33.16	46	-16.64	23.8	4.24	31.84	111	169	Peak
		A	Intenna P	olarity &	Test Dista	ance: Vert	ical at 3 r	n		
Frequency (MHz)	Emission Level (dBuV/m)	Read Level (dBuV)	Limit (dBuV/m)	Margin (dB)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Antenna Height (cm)	Table Angle (Degree)	Remark
44.55	20.81	37.84	40	-19.19	13.6	0.51	31.14	111	158	Peak
168.71	15.43	34.25	43.5	-28.07	11.86	1.06	31.74	201	236	Peak
450.98	20.31	33.65	46	-25.69	16.35	2.29	31.98	111	184	Peak
652.74	24.95	33.59	46	-21.05	20.24	3.12	32	111	132	Peak
858.38	27.98	33.02	46	-18.02	22.98	3.87	31.89	201	256	Peak
938.89	29.22	33.25	46	-16.78	23.73	4.18	31.94	111	174	Peak

Remarks:

1. Emission Level = Read Level + Antenna Factor + Cable Loss - Preamp Factor Margin value = Emission level – Limit value

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4.2 Conducted Emission Measurement

4.2.1 Limits of Conducted Emission Measurement

Fraguency (MH=)	Conducted I	Limit (dBuV)
Frequency (MHz)	Quasi-peak	Average
0.15 - 0.5	66 - 56	56 - 46
0.50 - 5.0	56	46
5.0 - 30.0	60	50

Note: 1. The lower limit shall apply at the transition frequencies.

2. The limit decreases in line with the logarithm of the frequency in the range of 0.15 to 0.50 MHz.

4.2.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Date Of Calibration	Due Date Of Calibration
Test Receiver ROHDE & SCHWARZ	ESCI	100613	Nov. 23, 2017	Nov. 22, 2018
RF signal cable (with 10dB PAD) Woken	5D-FB	Cable-cond1-01	Sep. 05, 2017	Sep. 04, 2018
LISN/AMN ROHDE & SCHWARZ (EUT)	ESH3-Z5	835239/001	Mar. 10, 2017	Mar. 09, 2018
LISN/AMN ROHDE & SCHWARZ (Peripheral)	ESH3-Z5	100311	Aug. 15, 2017	Aug. 14, 2018
Software ADT	BV ADT_Cond_ V7.3.7.3	NA	NA	NA

Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

- 2. The test was performed in HwaYa Shielded Room 1.
- 3. The VCCI Site Registration No. is C-2040.

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4.2.3 Test Procedures

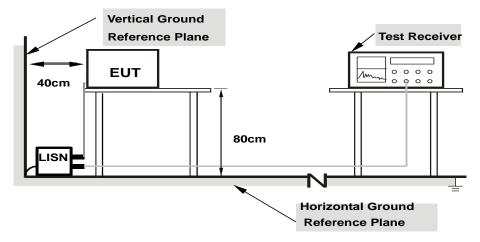
- a. The EUT was placed 0.4 meters from the conducting wall of the shielded room with EUT being connected to the power mains through a line impedance stabilization network (LISN). Other support units were connected to the power mains through another LISN. The two LISNs provide 50 ohm/ 50 uH of coupling impedance for the measuring instrument.
- b. Both lines of the power mains connected to the EUT were checked for maximum conducted interference.
- c. The frequency range from 150 kHz to 30 MHz was searched. Emission levels under (Limit 20 dB) was not recorded.

Note: All modes of operation were investigated and the worst-case emissions are reported.

4.2.4 Deviation from Test Standard

No deviation.

4.2.5 Test Setup



Note: 1.Support units were connected to second LISN.

2.Both of LISNs (AMN) are 80 cm from EUT and at least 80 from other units and other metal planes

For the actual test configuration, please refer to the attached file (Test Setup Photo).

4.2.6 EUT Operating Condition

Set the EUT under transmission condition continuously at specific channel frequency.

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4.2.7 Test Results

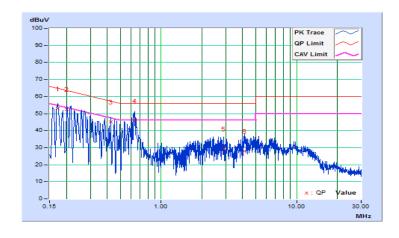
CONDUCTED WORST-CASE DATA: 8DPSK

Frequency Range	150kHz ~ 30MHz	Detector Function & Resolution Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz				
Input Power	120Vac, 60Hz	Environmental Conditions	25℃, 65%RH				
Tested by	Getaz Yang	Test Date	2018/2/27				

	Phase Of Power : Line (L)									
	Frequency	Correction	Readin	g Value	Emissio	n Level	Lir	nit	Mai	rgin
No		Factor	(dB	uV)	(dB	uV)	(dB	uV)	(d	B)
	(MHz)	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.17328	10.10	42.85	26.16	52.95	36.26	64.80	54.80	-11.85	-18.54
2	0.20084	10.10	42.42	24.92	52.52	35.02	63.58	53.58	-11.06	-18.56
3	0.42761	10.12	34.98	21.37	45.10	31.49	57.30	47.30	-12.20	-15.81
4	0.63484	10.13	35.63	21.29	45.76	31.42	56.00	46.00	-10.24	-14.58
5	2.89482	10.23	19.12	9.48	29.35	19.71	56.00	46.00	-26.65	-26.29
6	4.12647	10.29	17.82	7.97	28.11	18.26	56.00	46.00	-27.89	-27.74

Remarks:

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value



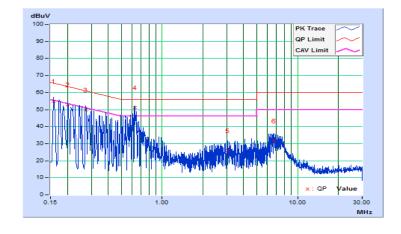


Frequency Range	150kHz ~ 30MHz	Detector Function & Resolution Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz
Input Power	120Vac, 60Hz	Environmental Conditions	25℃, 65%RH
Tested by	Getaz Yang	Test Date	2018/2/27

	Phase Of Power : Neutral (N)									
	Frequency	Correction	Readin	g Value	Emissio	n Level	Lir	nit	Mai	gin
No		Factor	(dB	uV)	(dB	uV)	(dB	uV)	(d	B)
	(MHz)	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.15782	10.10	44.78	27.29	54.88	37.39	65.58	55.58	-10.70	-18.19
2	0.20084	10.10	42.68	24.54	52.78	34.64	63.58	53.58	-10.80	-18.94
3	0.27120	10.11	39.67	22.56	49.78	32.67	61.08	51.08	-11.30	-18.41
4	0.62689	10.12	41.15	26.25	51.27	36.37	56.00	46.00	-4.73	-9.63
5	3.03167	10.22	15.63	4.45	25.85	14.67	56.00	46.00	-30.15	-31.33
6	6.72662	10.38	21.38	10.33	31.76	20.71	60.00	50.00	-28.24	-29.29

Remarks:

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value



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4.3 Number of Hopping Frequency Used

4.3.1 Limits of Hopping Frequency Used Measurement

At least 15 channels frequencies, and should be equally spaced.

4.3.2 Test Setup



4.3.3 Test Instruments

Refer to section 4.1.2 to get information of above instrument.

4.3.4 Test Procedure

- a. Check the calibration of the measuring instrument (SA) using either an internal calibrator or a known signal from an external generator.
- b. Turn on the EUT and connect its antenna terminal to measurement via a low loss cable. Then set it to any one measured frequency within its operating range and make sure the instrument is operated in its linear range.
- c. Set the SA on MaxHold Mode, and then keep the EUT in hopping mode. Record all the signals from each channel until each one has been recorded.
- d. Set the SA on View mode and then plot the result on SA screen.
- e. Repeat above procedures until all frequencies measured were complete.

4.3.5 Deviation from Test Standard

No deviation.

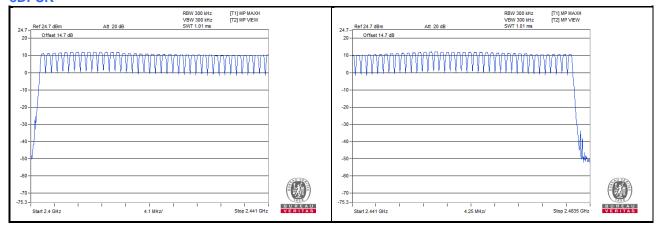
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4.3.6 Test Results

There are 79 hopping frequencies in the hopping mode. Please refer to next page for the test result. On the plots, it shows that the hopping frequencies are equally spaced.

8DPSK



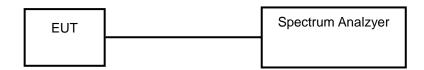


4.4 Dwell Time on Each Channel

4.4.1 Limits of Dwell Time on Each Channel Measurement

The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed.

4.4.2 Test Setup



4.4.3 Test Instruments

Refer to section 4.1.2 to get information of above instrument.

4.4.4 Test Procedures

- a. Check the calibration of the measuring instrument (SA) using either an internal calibrator or a known signal from an external generator.
- b. Turn on the EUT and connect its antenna terminal to measurement via a low loss cable. Then set it to any one measured frequency within its operating range and make sure the instrument is operated in its linear range.
- c. Adjust the center frequency of SA on any frequency be measured and set SA to zero span mode. And then, set RBW and VBW of spectrum analyzer to proper value.
- d. Measure the time duration of one transmission on the measured frequency. And then plot the result with time difference of this time duration.
- e. Repeat above procedures until all different time-slot modes have been completed.

4.4.5 Deviation from Test Standard

No deviation.

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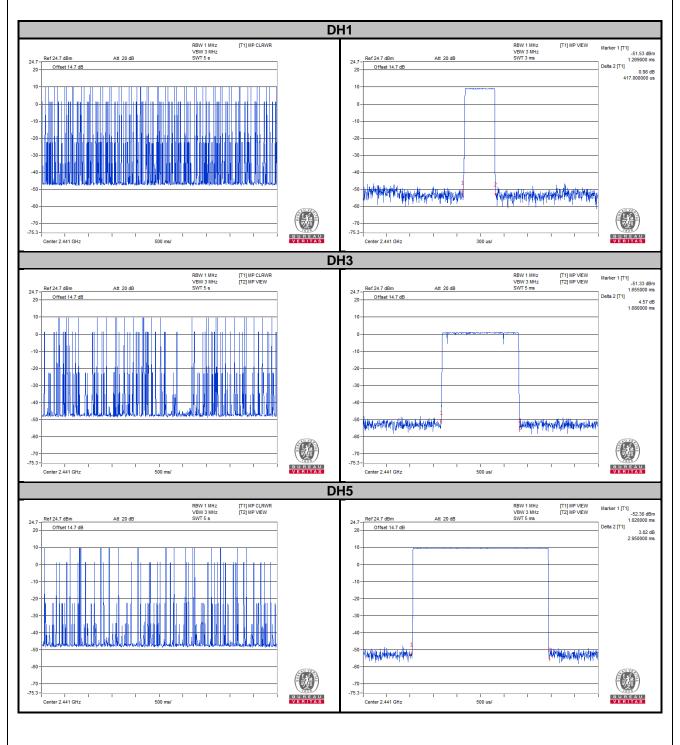


4.4.6 Test Results

GFSK

Mode	Number of transmission in a 31.6 (79 Hopping*0.4)	Length of transmission time (msec)	Result (msec)	Limit (sec)
DH1	50 (times / 5 sec) * 6.32 = 316 times	0.411	129.88	0.4
DH3	27 (times / 5 sec) * 6.32 = 170.64 times	1.68	286.68	0.4
DH5	17 (times / 5 sec) * 6.32 = 107.44 times	2.95	316.95	0.4

Note: Test plots of the transmitting time slot are shown as below.





Π/4-DQPSK

Mode	Number of transmission in a 31.6 (79 Hopping*0.4)	Length of transmission time (msec)	Result (msec)	Limit (sec)
2DH1	50 (times / 5 sec) * 6.32 = 316 times	0.417	131.77	0.4
2DH3	27 (times / 5 sec) * 6.32 = 170.64 times	1.685	287.53	0.4
2DH5	16 (times / 5 sec) * 6.32 = 101.12 times	2.93	296.28	0.4

Note: Test plots of the transmitting time slot are shown as below.





8DPSK

Mode	Number of transmission in a 31.6 (79 Hopping*0.4)	Length of transmission time (msec)	Result (msec)	Limit (sec)
3DH1	51 (times / 5 sec) * 6.32 = 322.32 times	0.411	132.47	0.4
3DH3	26 (times / 5 sec) * 6.32 = 164.32 times	1.675	275.24	0.4
3DH5	16 (times / 5 sec) * 6.32 = 101.12 times	0.51	51.571	0.4

Note: Test plots of the transmitting time slot are shown as below.



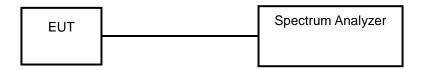


4.5 **Channel Bandwidth**

4.5.1 Limits of Channel Bandwidth Measurement

For frequency hopping system operating in the 2400-2483.5 MHz, if the 20 dB bandwidth of hopping channel is greater than 25 kHz, two-thirds 20 dB bandwidth of hopping channel shell be a minimum limit for the hopping channel separation.

4.5.2 Test Setup



4.5.3 **Test Instruments**

Refer to section 4.1.2 to get information of above instrument.

4.5.4 Test Procedure

- a. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
- b. Turn on the EUT and connect it to measurement instrument. Then set it to any one convenient frequency within its operating range. Set a reference level on the measuring instrument equal to the highest peak value.
- c. Measure the frequency difference of two frequencies that were attenuated 20 dB from the reference level. Record the frequency difference as the emission bandwidth.
- Repeat above procedures until all frequencies measured were complete.

4.5.5 **Deviation from Test Standard**

No deviation.

EUT Operating Condition 4.5.6

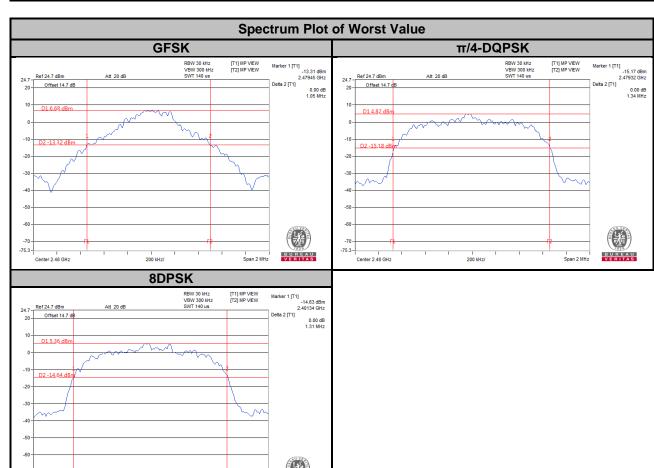
The software provided by client enabled the EUT to transmit and receive data at lowest, middle and highest channel frequencies individually.

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4.5.7 Test Results

Channel	Frequency	20 dB Bandwidth (MHz)					
Chainlei	(MHz)	GFSK	π/4-DQPSK	8DPSK			
0	2402	1.04	1.33	1.31			
39	2441	1.05	1.33	1.31			
78	2480	1.05	1.34	1.31			



200 kHz/

Center 2.402 GHz

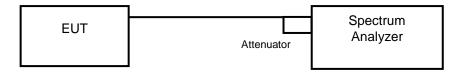
Span 2 MHz

VERITAS



Occupied Bandwidth Measurement 4.6

Test Setup 4.6.1



4.6.2 Test Instruments

Refer to section 4.1.2 to get information of above instrument

4.6.3 **Test Procedure**

The transmitter output was connected to the spectrum analyzer through an attenuator. The bandwidth of the fundamental frequency was measured by spectrum analyzer with resolution bandwidth in the range of 1 % to 5 % of the anticipated emission bandwidth, and a video bandwidth at least 3x the resolution bandwidth and set the detector to PEAK. The width of a frequency band such that, below the lower and above the upper frequency limits, the mean powers emitted are each equal to a specified percentage 0.5 % of the total mean power of a given emission.

4.6.4 **Deviation from Test Standard**

No deviation.

EUT Operating Conditions 4.6.5

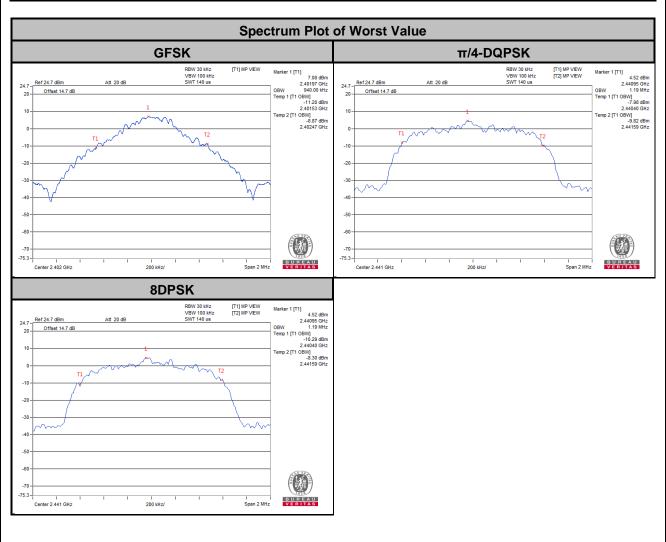
The software provided by client to enable the EUT under transmission condition continuously at lowest, middle and highest channel frequencies individually.

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4.6.6 Test Results

Channel	Frequency	Occupied Bandwidth (MHz)					
Chainlei	(MHz)	GFSK	π/4-DQPSK	8DPSK			
0	2402	0.94	1.19	1.18			
39	2441	0.93	1.19	1.19			
78	2480	0.92	1.19	1.18			





4.7 Hopping Channel Separation

4.7.1 Limits of Hopping Channel Separation Measurement

At least 25 kHz or two-third of 20 dB hopping channel bandwidth (whichever is greater).

4.7.2 Test Setup



4.7.3 Test Instruments

Refer to section 4.1.2 to get information of above instrument.

4.7.4 Test Procedure

Measurement Procedure REF

- a. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
- b. Turn on the EUT and connect it to measurement instrument. Then set it to any one convenient frequency within its operating range.
- c. By using the MaxHold function record the separation of two adjacent channels.
- d. Measure the frequency difference of these two adjacent channels by SA MARK function. And then plot the result on SA screen.
- e. Repeat above procedures until all frequencies measured were complete.

4.7.5 Deviation from Test Standard

No deviation.

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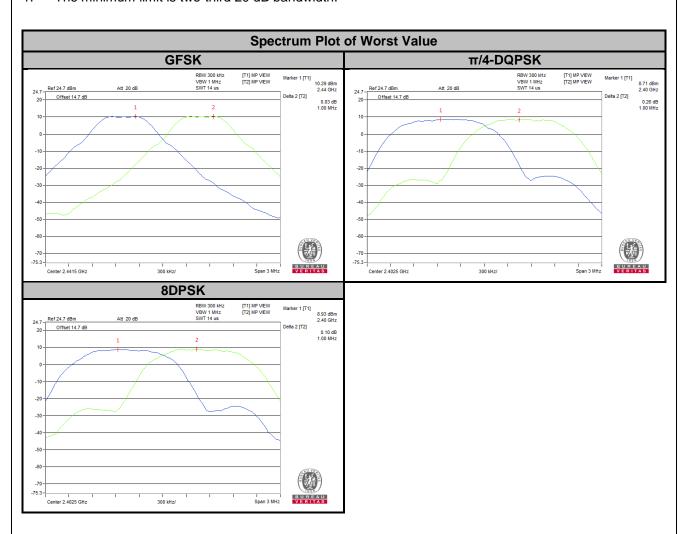


4.7.6 Test Results

Channel	Freq. (MHz)	·			20 dB Bandwidth (MHz)			Minimum Limit (MHz)			Pass / Fail
		GFSK	π/4-DQPSK	8DPSK	GFSK	π/4-DQPSK	8DPSK	GFSK	π/4-DQPSK	8DPSK	
0	2402	1.00	1.00	1.00	0.94	1.19	1.18	0.7	0.89	0.88	Pass
39	2441	1.00	1.00	1.00	0.93	1.19	1.19	0.7	0.89	0.88	Pass
78	2480	1.00	1.00	1.00	0.92	1.19	1.18	0.7	0.9	0.88	Pass

Note:

1. The minimum limit is two-third 20 dB bandwidth.



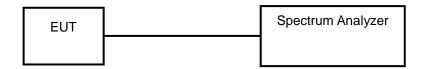


4.8 **Maximum Output Power**

4.8.1 Limits of Maximum Output Power Measurement

The Maximum Output Power Measurement is 125 mW.

4.8.2 Test Setup



4.8.3 Test Instruments

Refer to section 4.1.2 to get information of above instrument.

4.8.4 Test Procedure

- a. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
- Turn on the EUT and connect it to measurement instrument. Then set it to any one convenient frequency within its operating range. Set a reference level on the measuring instrument equal to the highest peak
- The center frequency of the spectrum analyzer is set to the fundamental frequency and using 3 MHz RBW and 10 MHz VBW.
- Measure the captured power within the band and recording the plot. d.
- Repeat above procedures until all frequencies required were complete.

4.8.5 Deviation from Test Standard

No deviation.

4.8.6 EUT Operating Condition

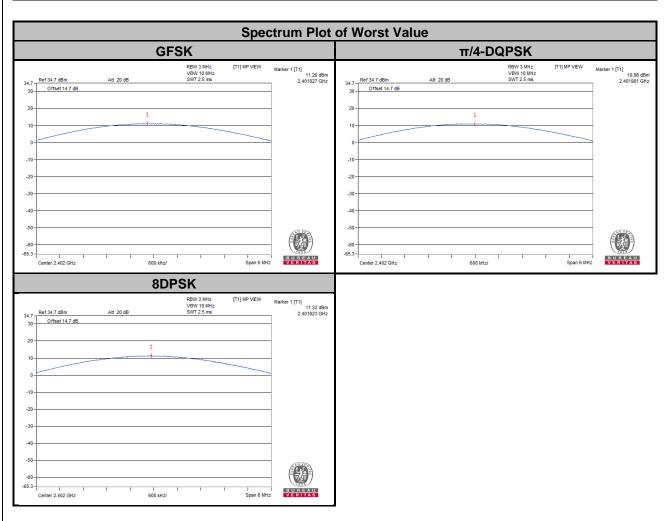
The software provided by client enabled the EUT to transmit and receive data at lowest, middle and highest channel frequencies individually.

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4.8.7 Test Results

Channel	Freq. (MHz)	. (11144)			C	Power Limit	Pass / Fail		
	(IVITIZ)	GFSK	π/4-DQPSK	8DPSK	GFSK	π/4-DQPSK	8DPSK	(mW)	nW) Fall
0	2402	13.183	12.531	13.552	11.20	10.98	11.32	125	Pass
39	2441	10.399	9.795	10.520	10.17	9.91	10.22	125	Pass
78	2480	11.429	10.789	11.641	10.58	10.33	10.66	125	Pass





4.9 Conducted Out of Band Emission Measurement

4.9.1 Limits Of Conducted Out Of Band Emission Measurement

Below –20 dB of the highest emission level of operating band (in 100 kHz RBW).

4.9.2 Test Instruments

Refer to section 4.1.2 to get information of above instrument.

4.9.3 Test Procedure

The transmitter output was connected to the spectrum analyzer via a low lose cable. Set both RBW and VBW of spectrum analyzer to 100 kHz and 300 kHz with suitable frequency span including 100 MHz bandwidth from band edge. The band edges was measured and recorded.

4.9.4 Deviation from Test Standard

No deviation.

4.9.5 EUT Operating Condition

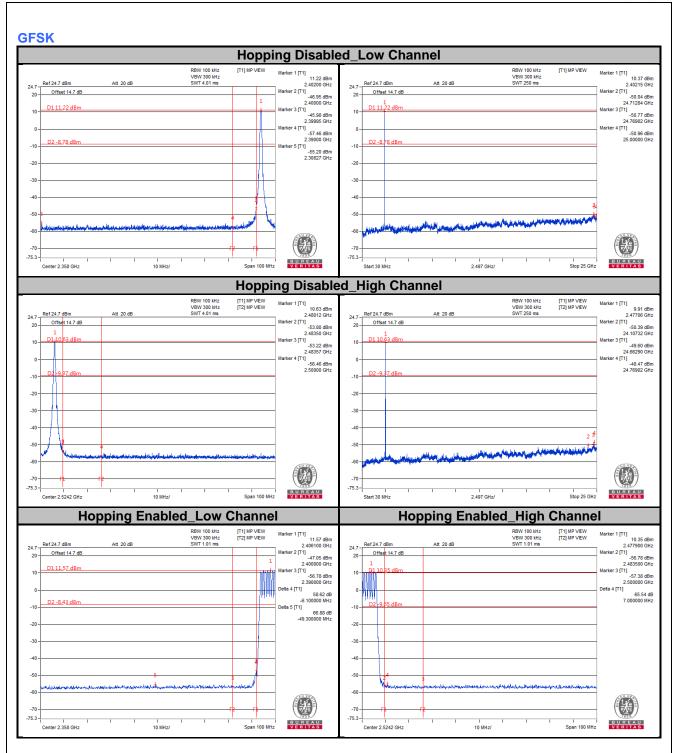
The software provided by client enabled the EUT to transmit and receive data at lowest, middle and highest channel frequencies individually.

4.9.6 Test Results

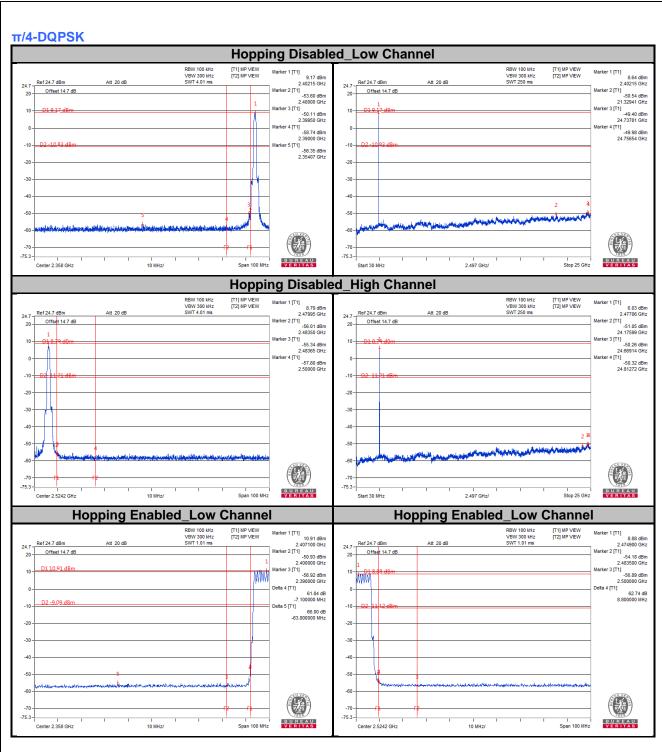
The spectrum plots are attached on the following images. D1 line indicates the highest level, D2 line indicates the 20 dB offset below D1. It shows compliance with the requirement.

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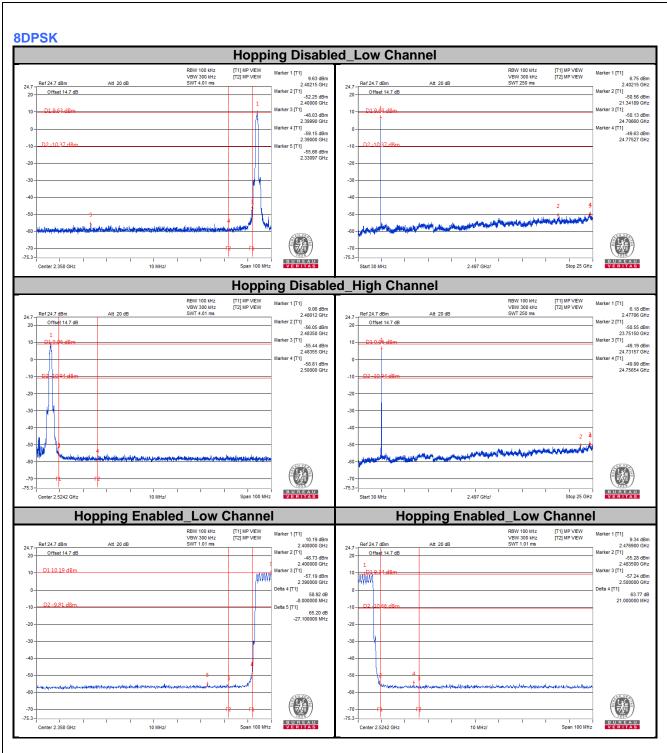














5 Pictures of Test Arrangements							
Please refer to the attached file (Test Setup Photo).							

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Appendix - Information on the Testing Laboratories

We, Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch, were founded in 1988 to provide our best service in EMC, Radio, Telecom and Safety consultation. Our laboratories are FCC recognized accredited test firms and accredited according to ISO/IEC 17025.

If you have any comments, please feel free to contact us at the following:

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The address and road map of all our labs can be found in our web site also.

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